

Search Notes**Application/Control No.**

10/756,945

Examiner

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Applicant(s)/Patent under Reexamination

LANDAU ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
606	116-117	9/28/2006	BHH
222	129, 135	9/28/2006	BHH
222	137, 82	9/28/2006	BHH
128	dig.6	9/28/2006	BHH
81	9.22	9/28/2006	BHH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/28/2006	BHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner